

BRAMMER STANDARD COMPANY, INC.

Certificate of Analysis

BS 4130

Certified Reference Material for AISI 4130 - UNS Number G41300

	Certified Value ¹	Estimate of Uncertainty ²	Certified Values³	Certified Value ¹	Estimate of Uncertainty ²
Al	0.0242	0.0006	S	0.0113	0.0004
As	0.0048	0.0005	Si	0.245	0.002
C	0.303	0.003	Sn	0.0099	0.0004
Ca	0.0007	0.0003	Ti	0.0009	0.0003
Co	0.0065	0.0003	V	0.0037	0.0003
Cr	0.924	0.006	W	0.0011	0.0002
Cu	0.221	0.002			
Mg	0.0002	0.0001			
Mn	0.541	0.005			
Mo	0.168	0.002			
N	0.0072	0.0005			
Nb	0.0015	0.0003			
Ni	0.088	0.001			
O	0.0015	0.0003			
P	0.0105	0.0004			

Informational Values^{3,4}

B (0.0002)	Fe [97.5]	Pb (0.00003)	Sb (0.0021)	Ta (0.0025)
Zr (0.0002)				

¹ For each element, the certified value listed is the present best estimate of the true value based on the mean of the weighted results of an interlaboratory testing program. See page 4 for more information on its calculation.

² For each element, the uncertainty listed is based on a statistical evaluation of the contributions of homogeneity and the interlaboratory testing program. See page 4 for more information on its calculation.

³ Values are given in weight percent.

⁴ Values in parentheses are not certified and are provided for information only.

Trace element information values for Ag, Bi, Cl, Ga, Ge, K, Na, and Zn are shown on page 4.

The requirements of ISO Guides 31, 34, and 35 were followed for the preparation of this Certified Reference Material and certificate of analysis. This is a Certified Reference Material as defined by ISO Guide 30.

Analysis	*	Al	*	As	*	C	*	Ca	*	Co	*	Cr	*	Cu	*	Mg
1	5	0.022267	16	0.003833	3	0.293	4	0.00057	4	0.0051	4	0.891333	5	0.207667	5	0.000113
2	3	0.0224	5	0.004433	1	0.297667	4	0.000583	4	0.0052	10	0.91	4	0.213033	5	0.000133
3	4	0.0226	15	0.00469	1	0.29925	3	0.00062	10	0.006	4	0.910533	10	0.216	11	0.00014
4	4	0.024	5	0.004767	1	0.299363	4	0.0008	4	0.00608	3	0.912	8	0.218	5	0.0002
5	4	0.0242	5	0.0049	1	0.301333	11	0.00092	4	0.006217	10	0.914325	3	0.22	5	0.000233
6	3	0.025	3	0.0049	1	0.301667			11	0.0063	4	0.914867	3	0.220	3	0.00031
7	4	0.025167	11	0.0050	3	0.302			4	0.0064	13	0.919	4	0.22	4	0.000397
8	3	0.0252	4	0.005867	1	0.304333			4	0.0064	4	0.920	10	0.22085	4	0.0004
9	4	0.0254			1	0.306667			3	0.0065	4	0.920667	4	0.221333		
10	4	0.0256			1	0.3100			8	0.006707	3	0.9254	4	0.221667		
11	10	0.025875			1	0.310167			5	0.006733	4	0.94	4	0.222		
12	11	0.0265			1	0.311			4	0.007	4	0.94	4	0.223333		
13	5	0.027067							5	0.0070	4	0.945	3	0.2249		
14									5	0.007333			4	0.225		
15									3	0.0076			4	0.225667		
16									10	0.00765			5	0.227		
Average		0.02415		0.00477		0.3028		0.00069		0.00649		0.9242		0.2209		0.000200
Std dev		0.00065		0.00035		0.0025		0.00011		0.00027		0.0060		0.0022		0.000043
H		0.0009		0.00041		0.0038		0.00022		0.00047		0.009		0.0031		0.00017
U ₁		0.0011		0.00054		0.0046		0.00025		0.00054		0.010		0.0038		0.00017
t-statistic		2.18		2.36		2.20		2.78		2.13		2.18		2.13		2.36
U ₂		0.0023		0.0013		0.010		0.00068		0.0012		0.023		0.0080		0.00041
U ₃		0.00065		0.00045		0.0029		0.00031		0.00029		0.0063		0.0020		0.00015
Certified		0.0242		0.0048		0.303		0.0007		0.0065		0.924		0.221		0.0002
Uncertainty		0.0006		0.0005		0.003		0.0003		0.0003		0.006		0.002		0.0001
Tolerance		0.0023		0.0013		0.010		0.0007		0.0012		0.023		0.008		0.0002

Analysis	*	Mn	*	Mo	*	N	*	Nb	*	Ni	*	O	*	P	*	S
1	4	0.535	4	0.16	2	0.0065	4	0.000833	10	0.08	2	0.001307	7	0.009687	1	0.009667
2	7	0.536333	4	0.164133	2	0.0071	3	0.0012	11	0.0810	2	0.001433	5	0.0098	1	0.010633
3	3	0.537	5	0.1643	2	0.007225	5	0.0013	5	0.081167	2	0.001467	4	0.009963	1	0.011
4	4	0.537333	10	0.167	2	0.007233	10	0.0018	7	0.083767	2	0.001567	4	0.010	3	0.0111
5	4	0.538	3	0.167	2	0.0073	3	0.0019	5	0.086067	2	0.001567	3	0.0104	1	0.0112
6	4	0.538667	4	0.167333	2	0.007383	4	0.002	4	0.086067	2	0.001575	10	0.0105	1	0.01155
7	4	0.54	10	0.167925	2	0.007467	10	0.002125	10	0.08705	4	0.010533	1	0.011553	10	0.0117
8	4	0.540333	7	0.168	2	0.0076			4	0.087833	5	0.010533	10	0.0117		
9	4	0.541167	3	0.169					4	0.088333	4	0.010767	1	0.011833		
10	3	0.542	4	0.169233					3	0.0885	10	0.0108	3	0.012		
11	10	0.543	3	0.1695					4	0.088667	3	0.011	1	0.012333		
12	3	0.5457	4	0.17					10	0.089	7	0.011067	1	0.012367		
13	10	0.54885	4	0.172					5	0.0890	4	0.011133	1	0.012567		
14			4	0.172333					3	0.0894	3	0.0118	1	0.013033		
15			13	0.172667					4	0.0895						
16									3	0.090						
17									4	0.092333						
Average		0.5406		0.1683		0.00721		0.00145		0.0878		0.00151		0.01047		0.01133
Std dev		0.0048		0.0019		0.00036		0.00017		0.0013		0.00017		0.00039		0.00034
H		0.0058		0.0026		0.00049		0.00027		0.0017		0.00028		0.00057		0.00059
U ₁		0.0075		0.0032		0.00061		0.00032		0.0022		0.00032		0.00069		0.00069
t-statistic		2.18		2.14		2.36		2.45		2.12		2.57		2.16		2.16
U ₂		0.016		0.0070		0.0014		0.00078		0.0046		0.00083		0.0015		0.0015
U ₃		0.0045		0.0018		0.00051		0.00029		0.0011		0.00034		0.00040		0.00040
Certified		0.541		0.168		0.0072		0.0015		0.088		0.0015		0.0105		0.0113
Uncertainty		0.005		0.002		0.0005		0.0003		0.001		0.0003		0.0004		0.0004
Tolerance		0.016		0.007		0.0014		0.0008		0.005		0.0008		0.0015		0.0015

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* Code for method

Certified values listed as weight percent

Analysis	*	Si	*	Sn	*	Ti	*	V	*	W
1	4	0.23	10	0.008275	4	0.0006	4	0.003133	4	0.0008
2	6	0.234	5	0.0091	5	0.0006	5	0.003167	11	0.0009
3	4	0.235967	3	0.0093	5	0.000633	4	0.00324	4	0.000983
4	4	0.236333	4	0.009433	11	0.00068	4	0.003333	4	0.001
5	4	0.238667	5	0.0095	5	0.0007	3	0.0035	5	0.001233
6	10	0.24	3	0.0098	3	0.0007	4	0.003533	5	0.0013
7	4	0.242667	9	0.009867	3	0.0008	10	0.00395	5	0.001333
8	10	0.242775	3	0.010	10	0.0009	10	0.0040	5	0.0016
9	4	0.243	5	0.010033	4	0.00140	3	0.0040		
10	3	0.245	4	0.010333	4	0.001483	4	0.004		
11	3	0.2455	10	0.0105	3	0.0015	4	0.004173		
12	3	0.246	4	0.010667	10	0.001575	11	0.0045		
13	5	0.2520	5	0.011467						
14	4	0.253333								
15	4	0.255667								
16	10	0.256667								
Average		0.2454		0.00990		0.00093		0.00368		0.00113
Std dev		0.0024		0.00033		0.00010		0.00021		0.00012
H		0.0033		0.00056		0.00024		0.00037		0.00025
U ₁		0.0041		0.00065		0.00026		0.00043		0.00028
t-statistic		2.13		2.18		2.20		2.20		2.36
U ₂		0.0087		0.0014		0.00057		0.00094		0.00066
U ₃		0.0022		0.00039		0.00017		0.00027		0.00023
Certified		0.245		0.0099		0.0009		0.0037		0.0011
Uncertainty		0.002		0.0004		0.0003		0.0003		0.0002
Tolerance		0.009		0.0014		0.0006		0.0009		0.0007

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* Code for method

Informational values listed as weight percent

Analysis	*	B	*	Fe	*	Pb	*	Sb	*	Ta	*	Zr
1	11	0.000065	4	97.41667	11	0.000027	11	0.0020	5	0.00001	5	0.000017
2	3	0.00009	3	97.44	5	0.000028	5	0.0021	5	0.000497	4	0.0001
3	5	0.0001	4	97.46617	5	0.0000433	4	0.002133	5	0.0008	10	0.000175
4	4	0.0001	10	97.76667			5	0.0024	10	0.0016	11	0.00019
5	3	0.00015							3	0.0047	4	0.000487
6	4	0.000167							3	0.0128		
7	7	0.00028										
8	4	0.000723										
Average		0.000159		97.48		0.000034		0.00213		0.00247		0.000140
Std dev		0.000051		0.27		0.000021		0.00030		0.00024		0.000046
H		0.00016		0.63		0.00014		0.00031		0.00032		0.00016
U ₁		0.00017		0.69		0.00014		0.00043		0.00040		0.00017
t-statistic		2.36		3.18		4.30		3.18		2.57		2.78
U ₂		0.00040		2.20		0.00061		0.0014		0.0010		0.00046
U ₃		0.00014		1.10		0.00035		0.00068		0.00042		0.00021
(Informational)		(0.0002)		[97.5]		(0.00003)		(0.0021)		(0.0025)		(0.0002)

For each element, in accordance with the requirements of ISO Guides 34 and 35, an effort must be made to account for the effects on the certified value of the uncertainty estimate from homogeneity testing (H) and the uncertainties of the contributing laboratories. The average (A) is calculated using a weighted mean where the reciprocal of the square of each laboratory's combined uncertainty (C_L), calculated from its standard deviation (S_L) and its uncertainty estimate (U_L), is used as the weight (W_L) for its mean (M_L). The standard deviation (S) is calculated as the square root of the reciprocal of the sum of the weights. U₁ is the combined uncertainty from homogeneity and labs. U₂ is U₁ times the coverage factor (95 % t-statistic). U₃ is U₂ divided by the square root of the number of determinations (n). Thus:

$$C_L = \sqrt{S_L^2 + U_L^2} \quad W_L = \frac{1}{C_L^2} \quad A = \frac{\sum_{i=1}^n W_L M_L}{\sum_{i=1}^n W_L} \quad S = \frac{1}{\sqrt{\sum_{i=1}^n W_L}} \quad U_1 = \sqrt{H^2 + S^2} \quad U_2 = t \times U_1 \quad U_3 = \frac{U_2}{\sqrt{n}}$$

All but the final reported values are taken to two significant figures as determined by each quantity's uncertainty estimate. The final reported Uncertainty is U₃ rounded to one significant figure and represents the half width of the 95 % confidence interval for the **Certified** value. The final reported **Certified** value is A rounded to the same decimal place as the Uncertainty. The Tolerance is the half width of the 95 % confidence interval for measurements rounded to the same decimal place as the Uncertainty. The Uncertainty is a measure of the quality of the **Certified** value. The Tolerance is a measure of the expected performance of an analysis.

For further information regarding the confidence interval for the certified value see ISO Guide 35:2006 section 6.

BS 4130

* Code for analytical method

Trace analysis listed as mg/kg (ppm)

Analysis	* Ag	* Bi	* Cl	* Ga	* Ge	* K	* Na	* Zn								
1	5	1.0	12	0.013	12	0.20	12	4.1	12	28	12	0.45	12	0.25	12	2.2

Analytical Method Codes:

- | | | | | | |
|---|-------------------------|----|-------------------------|----|------------------------|
| 1 | Combustion (ASTM E1019) | 7 | Photometric | 13 | Titrimetric |
| 2 | Fusion (ASTM E 1019) | 8 | Flame Atomic Absorption | 14 | DCP Atomic Emission |
| 3 | Spark Atomic Emission | 9 | GF Atomic Absorption | 15 | HG Atomic Fluorescence |
| 4 | ICP Atomic Emission | 10 | X-Ray Fluorescence | | |
| 5 | ICP Mass Spectrometry | 11 | GD Atomic Emission | | |
| 6 | Gravimetric | 12 | GD Mass Spectrometry | | |

ICP = Inductively Coupled Plasma GF = Graphite Furnace GD = Glow Discharge
DCP = Direct Current Plasma HG = Hydride Generation

Laboratory

Location

Registrar

Accreditation

ATI Allvac	Lockport, NY	ACCLASS	17025
Brammer Standard Company, Inc.	Houston, TX	A2LA	17025, Guide 34
Dirats Laboratories	Westfield, MA	ACCLASS	17025
Elemental Analysis, Inc.	Lexington, KY	A2LA	17025
Laboratory Testing, Inc.	Hatfield, PA	PRI/Nadcap	17025
LECO Corporation	St. Joseph, MI	A2LA	17025
NSL Analytical	Cleveland, OH	ACCLASS	17025
Shandong Metallurgical and Science Research	Jinan, China	CNAS	17025
Evans Analytical Group	Liverpool, NY	A2LA	17025
National Analysis Center For Iron And Steel	Beijing, China	CNAS	17025
Exova	Glendale Heights, IL	A2LA	17025
Northern Analytical Laboratory, Inc.	Londonderry, NH	PRI/Nadcap	17025
Instytut Metalurgii Zelaza	Gliwice, Poland	PCA	AB 554

A2LA = American Association for Laboratory Accreditation

ACCLASS = ANSI-ASQ National Accreditation Board

CNAS = China National Accreditation Service

Nadcap = National Aerospace and Defense Contractors Accreditation Program

PCA = Polish Center For Accreditation

PRI = Performance Review Institute

Analysis: Chemical analyses were made on solid pieces and chips prepared by a lathe from representative samples for the certified portion of the lot in accordance with ASTM Standard Practice E 1806. The laboratories participating in the testing followed the requirements of ISO Standard 17025. Methods of analysis used were a those listed on pages 2-4.

Traceability: The following Certified Reference Materials were used to validate the analytical data listed on pages 2-4 — 11XSG2, 12A41300, 12X44220, 13X32100, 13X41001, 28X7138; 501-024, 501-123, 501-320, 501-501, 501-503, 501-504, 501-506, 501-643, 501-644, 501-646, 501-674, 501-676, 501-953, 501-993, 502-072, 502-102, 502-257, 502-348, 502-416; BAS 180/2, 260/3, 261, 261/1, 331, 334, 345, 363, 434, 434/2, 464, 464/1, 474; BS CSN 2-2, 06J, 42, 207, 690, 2941; CZ 2015A; ECRM 281, 296; IARM 30C, 30D, 35H, 52, 143B, 143C, 209C; IMZ 1.7/4, 1.12/3, 130, 132, 139, 169, 176A, 177, 178; JSS 514-3; SRM C1151A, C1152A, 3109A, 3131A, 3155, 3163, 3169.

Homogeneity: This Certified Reference Material (CRM) was tested for homogeneity using ASTM Standard Method E 826 and found acceptable. It was also examined by spark atomic emission spectrometry and found to be compatible with the following Reference Materials — BS CSN 2-1, CSN 4, 06J, 207, 2941; ECRM 327-2; JSS 514-3; SRM 72G, 361.

Validity statement: ISO Guide 31 states that the certification should contain an expiration date for all materials where instability has been demonstrated or is considered possible, after which the certified value is no longer guaranteed by the certifying body. The certification of BS 4130 is valid indefinitely. The certification is nullified if this CRM is damaged, contaminated, or otherwise modified.

Source: The bar stock for this CRM was produced by Gerdau Special Steel North America, Jackson, MI.

Form: This CRM is machined in the form of a disc, approximately 38 mm in diameter and 19 mm thick by Brammer Standard Company, Inc.

Use: This CRM is intended for use in spark atomic emission and x-ray spectrometric methods of analysis. Refer to ISO Guide 33 for information about the use of Certified Reference Materials.

Certified Area: The entire depth of the CRM may be used.

Caution: As with any bar material, avoid spark atomic emission spectrometric burns in the center of the CRM (5 mm radius), as some segregation may be present.

Sample Preparation: For best analytical results, use the same method for preparing the analytical surface on all reference materials as you use for production specimens. Avoid overheating the sample during surface preparation.

Certificate Number: The unique identification number for this certificate of analysis is 4130-101513. You may obtain information on revisions of certificates from the internet at www.brammerstandard.com.

Safety Notice: A Material Safety Data Sheet (MSDS) is not required for this material. This material will not release or otherwise result in exposure to a hazardous chemical, under normal conditions of use. Inquiries concerning this Reference Material should be directed to:

Brammer Standard Co., Inc. Phone: (281) 440-9396 Web: www.brammerstandard.com
14603 Benfer Road
Houston, Texas 77069-2895 USA Fax: (281) 440-4432 Email: contact@brammerstandard.com

Brammer Standard Company, Inc., is accredited by the American Association For Laboratory Accreditation (A2LA) to ISO Guide 34 as a Reference Material Producer for the production of Certified Reference Materials and Reference Materials (Certificate Number 656.02)

Brammer Standard Company's Chemical Laboratory is accredited by A2LA to ISO Standard 17025. (Certificate Number 656.01)

By Certificate Number 10539, the Quality System of Brammer Standard Company, Inc., is registered to ISO 9001:2008 by National Quality Assurance (NQA), U.S.A.

The scopes of accreditation are listed on the website: www.brammerstandard.com

References:

Versions used were those available at the time of testing and characterization

- E 826 Standard Practice for Testing Homogeneity of a Metal Lot or Batch in Solid Form by Spark Atomic Emission Spectrometry
- E 1019 Standard Test Methods for Determination of Carbon, Sulfur, Nitrogen, and Oxygen in Steel, Iron, Nickel, and Cobalt Alloys by Various Combustion and Fusion Techniques
- E 1806 Standard Practice for Sampling Steel and Iron for Determination of Chemical Composition
- ISO Standard 17025:2005 General requirements for the competence of testing and calibration laboratories
- ISO Standard 9001:2008 Quality Management Systems - Requirements
- ISO Guide 30:1992 Terms and definitions used in connection with reference materials + 2008 amendment
- ISO Guide 31:2000 Reference materials - Contents of certificates and labels
- ISO Guide 33:2000 Uses of certified reference materials
- ISO Guide 34:2009 General requirements for the competence of reference material producers
- ISO Guide 35:2006 Reference Materials - General and statistical principles for certification

ASTM documents available from ASTM, 1916 Race Street, Philadelphia, PA, 19103.

ISO Guides and Standards available from Global Engineering - www.global.ihs.com

Other useful documents available from NIST, U.S. Department of Commerce, Gaithersburg, MD 20899.

NIST Special Publication 260-100, Handbook for SRM Users

NIST Special Publication 829, Use of NIST Standard Reference Materials for Decisions on Performance of Analytical Chemical Methods and Laboratories

Certified by: _____ on October 15, 2013.

Beau R. Brammer